

AP6982GN2-HF

Halogen-Free Product

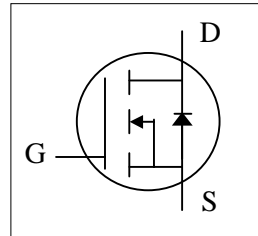


**Advanced Power
Electronics Corp.**

N-CHANNEL ENHANCEMENT MODE

POWER MOSFET

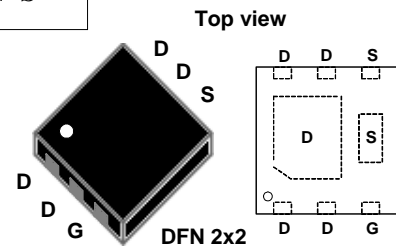
- ▼ Capable of 1.8V Gate Drive
- ▼ Small Size & Lower Profile
- ▼ Halogen Free & RoHS Compliant Product



BV_{DSS}	20V
$R_{DS(ON)}$	12.5m Ω
I_D	11A

Description

AP6982 series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-Source Voltage	± 8	V
$I_D@T_A=25^\circ C$	Continuous Drain Current ³ @ $V_{GS}=4.5V$	11	A
$I_D@T_A=70^\circ C$	Continuous Drain Current ³ @ $V_{GS}=4.5V$	8.7	A
I_{DM}	Pulsed Drain Current ¹	40	A
$P_D@T_A=25^\circ C$	Total Power Dissipation ³	2.4	W
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ C$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ C$

Thermal Data

Symbol	Parameter	Value	Unit
R_{thj-a}	Maximum Thermal Resistance, Junction-ambient ³	52	$^\circ C/W$



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Electrical Characteristics @T_j=25°C (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	20	-	-	V	
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =4.5V, I _D =10A	-	9.3	12.5	mΩ	
		V _{GS} =2.5V, I _D =5A	-	11.3	16	mΩ	
		V _{GS} =1.8V, I _D =2A	-	15	21	mΩ	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	0.3	0.5	1	V	
g _{fs}	Forward Transconductance	V _{DS} =5V, I _D =10A	-	34	-	S	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =16V, V _{GS} =0V	-	-	10	uA	
I _{GSS}	Gate-Source Leakage	V _{GS} =±8V, V _{DS} =0V	-	-	±100	nA	
Q _g	Total Gate Charge	I _D =10A	-	22	35.2	nC	
Q _{gs}	Gate-Source Charge		V _{DS} =10V	-	2.5	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge		V _{GS} =4.5V	-	7	-	nC
t _{d(on)}	Turn-on Delay Time	V _{DS} =10V	-	9	-	ns	
t _r	Rise Time	I _D =1A	-	13	-	ns	
t _{d(off)}	Turn-off Delay Time	R _G =3.3Ω	-	40	-	ns	
t _f	Fall Time	V _{GS} =5V	-	10	-	ns	
C _{iss}	Input Capacitance	V _{GS} =0V	-	1500	2400	pF	
C _{oss}	Output Capacitance	V _{DS} =10V	-	170	-	pF	
C _{riss}	Reverse Transfer Capacitance	f=1.0MHz	-	155	-	pF	
R _g	Gate Resistance	f=1.0MHz	-	2	4	Ω	

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ²	I _S =2A, V _{GS} =0V	-	-	1.2	V
t _{rr}	Reverse Recovery Time	I _S =10A, V _{GS} =0V, dI/dt=100A/μs	-	11	-	ns
Q _{rr}	Reverse Recovery Charge		-	5	-	nC

Notes:

1. Pulse width limited by Max. junction temperature.
2. Pulse test
3. Surface mounted on 1 in² 2oz copper pad of FR4 board, t ≤ 10s ; 165°C/W when mounted on min. copper pad.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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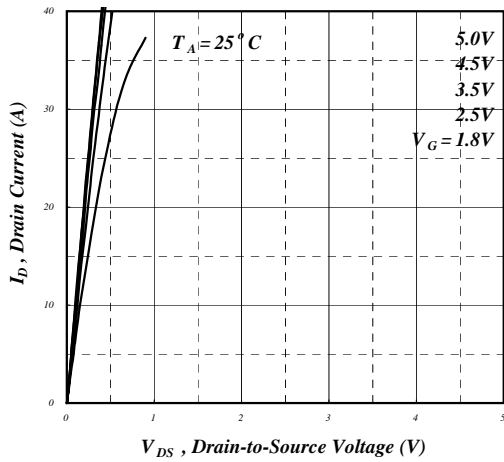


Fig 1. Typical Output Characteristics

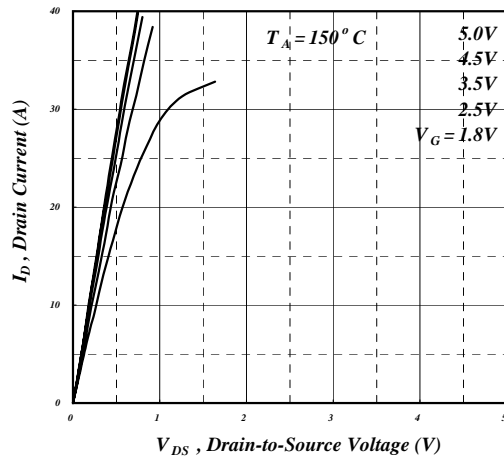


Fig 2. Typical Output Characteristics

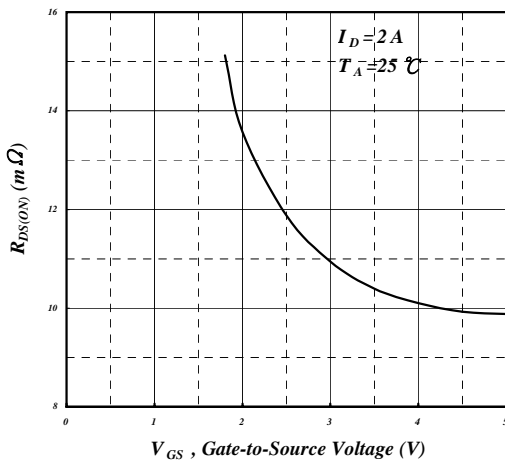


Fig 3. On-Resistance v.s. Gate Voltage

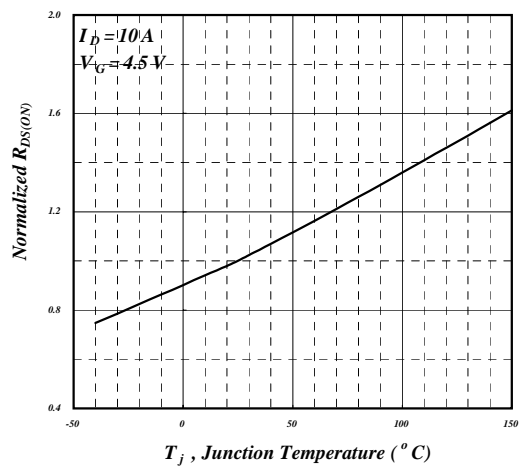


Fig 4. Normalized On-Resistance v.s. Junction Temperature

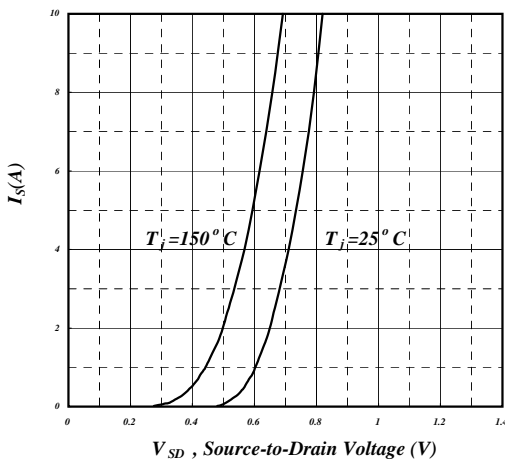


Fig 5. Forward Characteristic of Reverse Diode

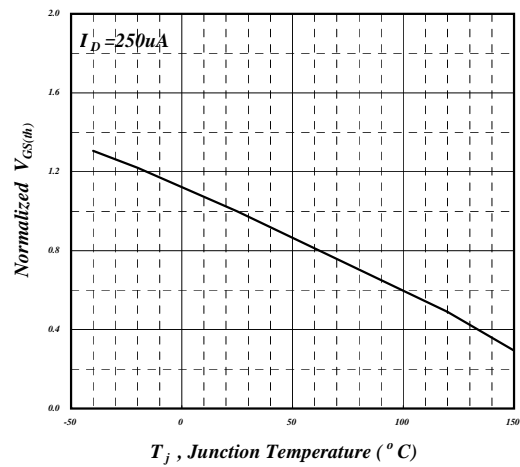


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

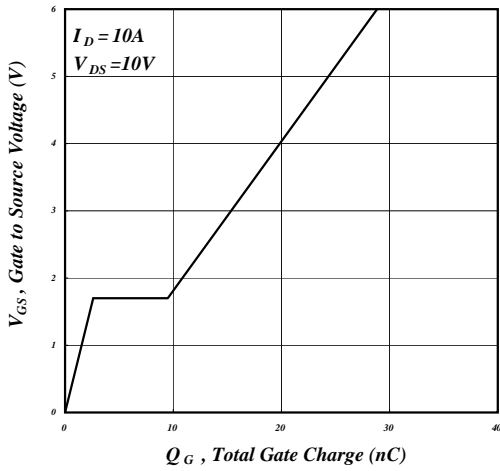


Fig 7. Gate Charge Characteristics

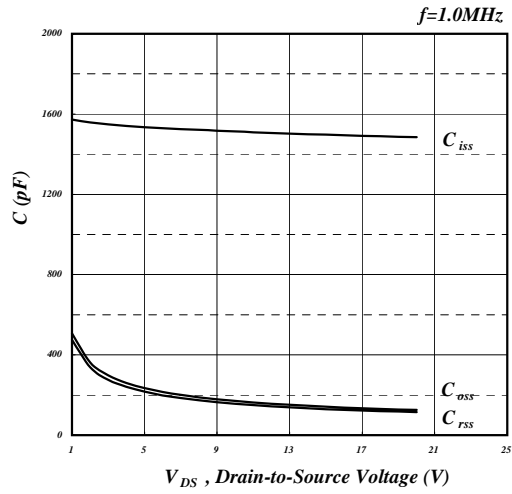


Fig 8. Typical Capacitance Characteristics

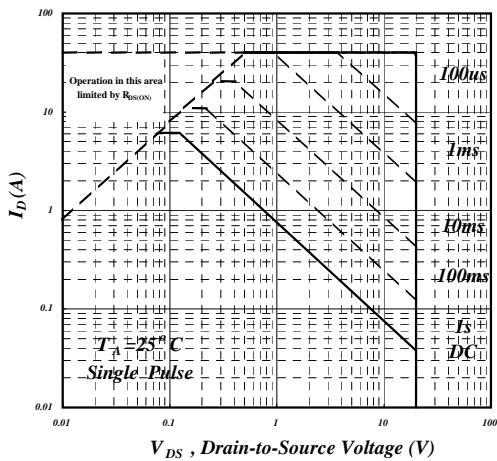


Fig 9. Maximum Safe Operating Area

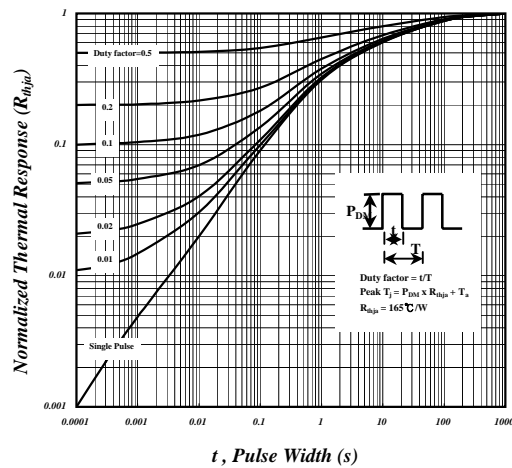


Fig 10. Effective Transient Thermal Impedance

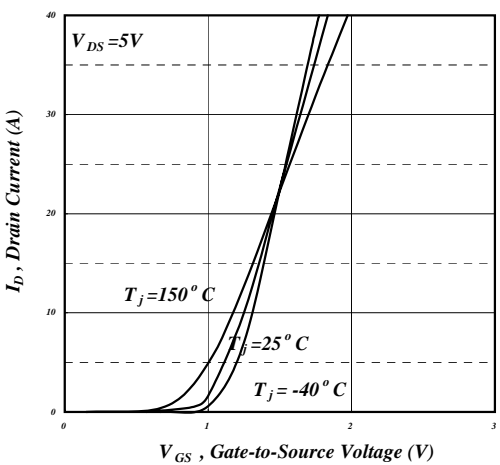


Fig 11. Transfer Characteristics

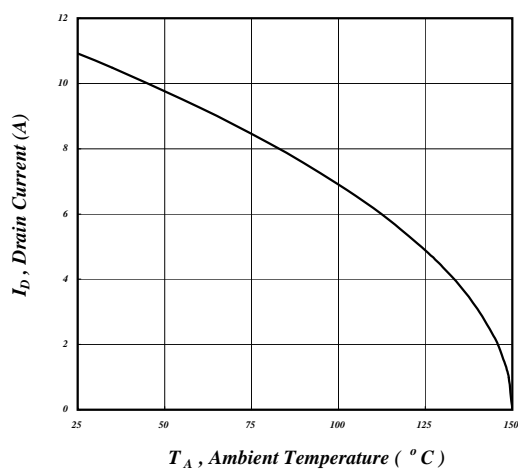


Fig 12. Maximum Continuous Drain Current v.s. Ambient Temperature